Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

214491US2X

SERIAL NO.

09/965,073

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Yuki WAKITA, et al.

FILING DATE

September 28, 2001

GROUP

2171

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

RECEIVED

JAN 05 2004

Technology Center 2100

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
BP	AO	1075321 (1116029A)	11/21/2001	CHINA (with English Abstract of WO 95/07004)		X
BP	AP	1198288	11/04/1998	CHINA (with English Abstract of WO 97/46021)		X
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

BOS

Date Considered

2/2/05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
214491US2X

JUN 27 2003

SERIAL NO.
09/965,073

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Yuki WAKITA, et al.FILING DATE
September 28, 2001GROUP
2171

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

RECEIVED

JUN 30 2003

Technology Center 2100

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
Bp	AO	05-227477	03/09/93	JAPAN (with partial English translation)		
Bl	AP	07-303234	11/14/95	JAPAN (with partial English translation)		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

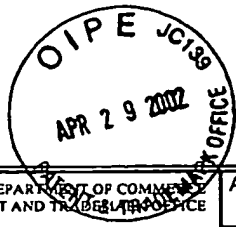
	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 214491US2X		SERIAL NO. 09/965,073	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yuki WAKITA, et al.			
				FILING DATE September 28, 2001		GROUP 2171	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
BP	AA	5,537,528	07/16/96	J. TAKAHASHI, et al.			
BP	AB	5,442,744	08/15/95	M. PIECH, et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
BP	AO	0 843 311	05/20/98	EUROPE			
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner B5A					Date Considered 2/2/05		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
214491US2XSERIAL NO.
NEW APPLICATION

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Yuki WAKITA, et al.

FILING DATE
HEREWITH

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
B1	AM	2000-56955	02/25/00	JAPAN (with English Abstract)		X
B1	AN	5-204652	08/13/93	JAPAN (with English Abstract)		X
B1	AO	6-215095	08/05/94	JAPAN (with English Abstract)		X
B1	AP	7-141162	06/02/95	JAPAN (with English Abstract)		X
B1	AQ	8-6756	01/12/96	JAPAN (with English Abstract)		X
B1	AR	9-34680	02/07/97	JAPAN (with English Abstract)		X
B1	AS	2000-80716	03/21/00	JAPAN (with English Abstract)		X
B1	AT	10-276449	10/13/98	JAPAN (with English Abstract)		X
B1	AU	11-66820	03/09/99	JAPAN (with English Abstract)		X
B1	AV	11-136621	05/21/99	JAPAN (with English Abstract)		X

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner

Date Considered

2/2/05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

DC979 U.S. PTO
09/965073

09/28/01